Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/650,367	VILHONEN ET AL.	
Examiner	Art Unit	
Joseph Chang	2817	

SEARCHED				
Class	Subclass	Date	Examiner	
331	17,16 34	2/17/2005	1C	
327	553,554			
327	557,156			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				

SEAR(INCLUDING SE	CH NOTES EARCH STRATEGY)
	DATE	EXMR
EAST(attached)	2/17/2005	1C